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## FEATURES OF STRUCTURAL, ENERGETIC, ELECTROKINETIC INVESTIGATION OF ENERGY AND ELECTROKINETIC CHARACTERISTICS OF THERMOELECTRIC MATERIAL $TiCo_{1-x}Mn_xSb$

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*The crystal and electronic structure, temperature and concentration dependences of the resistivity and the Seebeck coefficient of the thermoelectric material  $TiCo_{1-x}Mn_xSb$ ,  $x = 0.01-0.10$ , in the temperature range  $T = 80-400$  K have been studied. It was shown that the doping of the initial  $TiCoSb$  semiconductor by  $Mn$  atoms is accompanied by the simultaneous generation of structural defects of acceptor and donor nature and the appearance in the band gap of acceptor band  $\epsilon_A$  (substitution of  $Co$  atoms by  $Mn$  ones) and also donor bands  $\epsilon_D^1$  and  $\epsilon_D^2$  of different nature. The concentration ratio of the ionized acceptors and donors generated in  $TiCo_{1-x}Mn_xSb$  determines the position of the Fermi level  $\epsilon_F$  and the mechanisms of electrical conductivity of the thermoelectric material. Bibl. 14, Fig. 7.*

**Keywords:** electronic structure, electrical resistivity, Seebeck coefficient.

### Introduction

One of the ways to obtain semiconductor thermoelectric materials with high efficiency of thermal into electrical energy conversion is doping of the base semiconductor by impurity atoms, which generate structural defects of donor and/or acceptor nature in the crystal. This allows purposeful changing the values of conductivity  $\sigma$ , the Seebeck coefficient  $\alpha$  and thermal conductivity  $\kappa$  to obtain the maximum values of thermoelectric figure of merit  $Z$  ( $Z = \alpha^2 \cdot \sigma / \kappa$ ) [1].

The results of studies of a new semiconductor thermoelectric material  $TiCo_{1-x}Mn_xSb$ ,  $x = 0.01-0.10$ , obtained by doping the base semiconductor  $TiCoSb$  ( $MgAgAs$  structure type, space group  $Fm\bar{4}3m$  [2]) by  $Mn$  atoms ( $3d^5 4s^2$ ) by replacing of  $Co$  ( $3d^7 4s^2$ ), are given below. It was expected that the substitution of  $Co$  atoms by  $Mn$  would generate structural defects of acceptor nature in the  $TiCo_{1-x}Mn_xSb$  semiconductor (the  $Mn$  atom has fewer  $3d$ -electrons than  $Co$ ), which would allow

us to control the position of the Fermi level  $\epsilon_F$  and change the values of its electrokinetic characteristics.

In [3], the authors showed that the structure of the base semiconductor  $TiCoSb$  is defective. Thus, there are vacancies (Va) ( $\sim 1\%$ ) in the crystallographic position  $4a$  of  $Ti$  atoms, and additional  $Co^*$  atoms (up to  $\sim 1\%$ ) are located in the tetrahedral voids of the structure, which occupy  $\sim 24\%$  of the unit cell volume [2]. As result, the formula of the  $TiCoSb$  semiconductor is transformed into  $(Ti_{0.99}Va_{0.01})Co(Co^*_{0.01})Sb$ . Vacancies generate structural defects of acceptor nature in position  $4a$  of  $Ti$  atoms, and the corresponding acceptor band  $\epsilon_A$  appears in the band gap  $\epsilon_g$ . Additional  $Co^*$  atoms generate defects of donor nature in the tetrahedral voids of the semiconductor structure, and the donor band  $\epsilon_D$  appears in the band gap  $\epsilon_g$ .

All described above explains the nature of the mechanism of simultaneous "a priori" doping of the initial  $TiCoSb$  semiconductor by donor and acceptor impurities, which makes it heavily doped and highly compensated [4]. Taking into account that the Fermi level  $\epsilon_F$  in  $TiCoSb$  lies within the band gap between the states of ionized donors and acceptors, the changes in the ratio between them caused, for example, by the modes of thermal annealing of samples and their cooling, purity of initial components, etc., will shift the position of the Fermi level  $\epsilon_F$  relative to impurity bands and continuous energies bands. For this reason, the compound  $TiCoSb$  is a semiconductor of the hole-type conductivity at temperatures  $T < 90$  K, which is indicated by positive values of the Seebeck coefficient  $\alpha$ , and at higher temperatures the majority carriers are electrons. This temperature dependence of the type of the majority carriers also indicates a different depth of energy levels: the acceptor states are smaller and ionized at lower temperatures than the donor ones.

Semiconductor thermoelectric materials based on  $TiCoSb$  were reported in [3-9]. Thus, in  $Ti_{1-x}V_xCoSb$  and  $Ti_{1-x}Mo_xCoSb$  semiconductors, structural defects of acceptor nature are simultaneously generated as vacancies in the positions of  $Ti$  and  $Co$  atoms, and occupation of  $4a$  positions of  $Ti$  atoms by  $V$  or  $Mo$  atoms generates defects of donor nature. The mechanism of simultaneous appearance of acceptors and donors provides the semiconductor properties of  $Ti_{1-x}V_xCoSb$  and  $Ti_{1-x}Mo_xCoSb$ . Doping of  $TiCoSb$  by  $Sc$  atoms ( $3d^14s^2$ ) introduced by substitution of  $Ti$  atoms ( $3d^24s^2$ ) generates structural defects of acceptor nature in  $Ti_{1-x}Sc_xCoSb$  ( $Sc$  atom has fewer  $3d$ -electrons than  $Ti$ ), and the ratio of defects of donor and acceptor nature determines the position of the Fermi level  $\epsilon_F$  in the band gap  $\epsilon_g$  and the mechanisms of electrical conductivity.

The study of the semiconductor thermoelectric material  $TiCo_{1-x}Ni_xSb$  revealed a linear variation in the value of the unit cell parameter  $a(x)$ , which indicates the substitution of  $Co$  atoms by  $Ni$  ones. In this case, donors are generated in the crystal, because the  $Co$  atom ( $3d^74s^2$ ) has a smaller number of  $3d$ -electrons than the  $Ni$  atom ( $3d^84s^2$ ). The thermoelectric material  $TiCo_{1-x}Cu_xSb$  has a different behaviour of structural parameters depending on the impurity concentration.

The presented results of studying the electrokinetic and energy characteristics of the semiconductor solid solution  $TiCo_{1-x}Mn_xSb$ ,  $x = 0.01-0.10$ , as well as their comparison with the results of modeling the electronic structure, will help to identify the mechanisms of electrical conductivity in order to determine the conditions of synthesis of thermoelectric materials with maximum efficiency of thermal energy into electrical energy conversion.

## Investigation procedures

$TiCo_{1-x}Mn_xSb$  samples were synthesized by arc-melting the charge of the constituent components (the content of the main component not less than 99.9 wt.%) in an electric arc furnace in

an inert atmosphere followed by homogenizing annealing for 720 h at 1073 K. Excess 1–3 wt. % *Sb* was used to compensate for losses during the electric arc-melting procedure. The chemical and phase compositions of the samples were examined by X-ray phase (DRON-4.0 diffractometer, *FeK $\alpha$*  radiation) and metallographic analyses (TESKAN VEGA 3 LMU electron microscope equipped with an X-ray analyzer with energy dispersion spectroscopy (EDRS)). The structural parameters of the solid solution *TiCo<sub>1-x</sub>Mn<sub>x</sub>Sb* samples were calculated using the Fullprof Suite program [10]. Modeling of the electronic structure of *TiCo<sub>1-x</sub>Mn<sub>x</sub>Sb* was performed by the KKR method (Corringa-Kohn-Rostoker method) in the approximation of the coherent potential CPA and local density LDA [11]. Licensed software AkaiKKR and SPR-KKR in the LDA approximation for the exchange-correlation potential with Moruzzi-Janak-Williams (MJW) parameterization were used for KKR calculations [12]. The Brillouin zone was divided into 1000 *k*-points, which were used to model energy characteristics by calculating DOS. The width of the energy window was 22 eV and was chosen to capture all semi-core states of p-elements. The full potential FP in the representation of plane waves was used in the calculations by the linear MT orbital method. The LDA approximation with MJW parameterization was used as the exchange-correlation potential. The accuracy of calculating the position of the Fermi level is  $\pm 4$  meV. Temperature and concentration dependences of electric resistivity ( $\rho$ ) and the Seebeck coefficient ( $\alpha$ ) relative to copper of *TiCo<sub>1-x</sub>Mn<sub>x</sub>Sb* were measured in the ranges:  $T = 80$ –400 K,  $x = 0.01$ –0.10.

### Research on structural characteristics of *TiCo<sub>1-x</sub>Mn<sub>x</sub>Sb*

Microprobe analysis of the concentration of atoms on the surface of *TiCo<sub>1-x</sub>Mn<sub>x</sub>Sb* samples established their correspondence to the initial compositions of the charge (Fig. 1), and X-ray phase and structural analyses showed that the powder patterns of samples, including the composition  $x=0$ –0.10, are indexed in the *MgAgAs* structure type and contain no traces of other phases. (Fig. 2a).

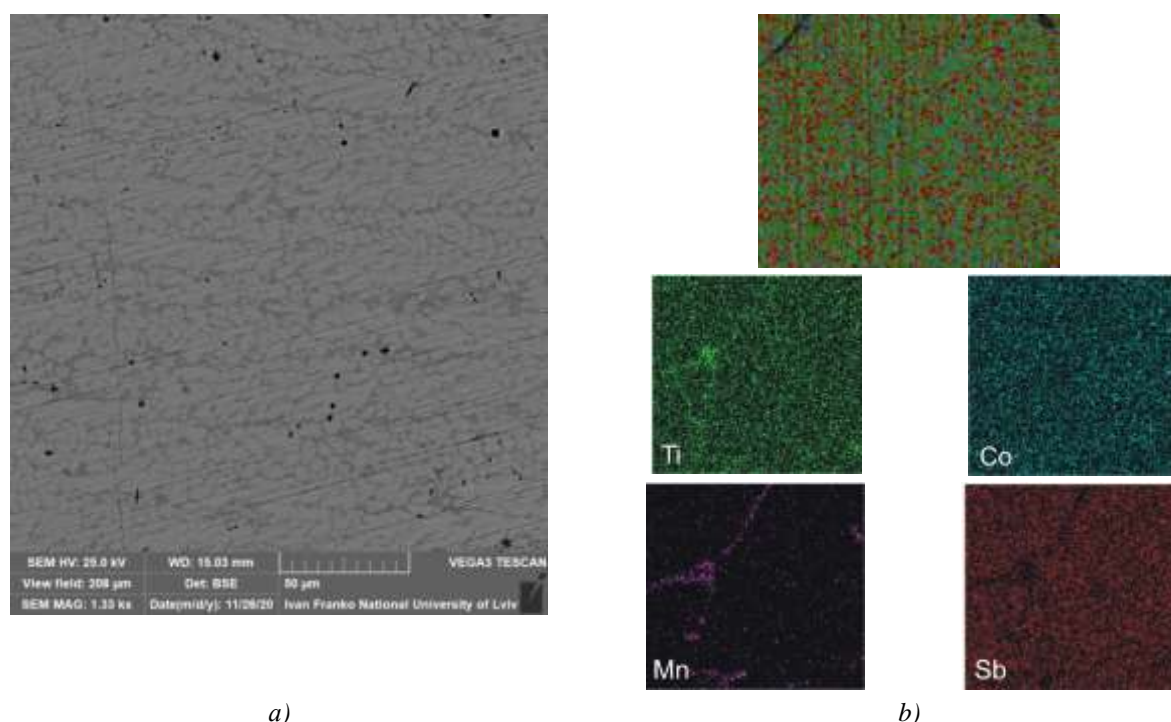


Fig. 1. Photograph of the surface (a) and distribution of elements (b) in the sample *TiCo<sub>0.95</sub>Mn<sub>0.05</sub>Sb*

Structural studies of  $TiCo_{1-x}Mn_xSb$  solid solution revealed the complex character of the inclusion of impurity  $Mn$  atoms into the semiconductor structure matrix. Since the atomic radius of  $Mn$  ( $r_{Mn} = 0.130$  nm) is larger than that of  $Co$  atom ( $r_{Co} = 0.125$  nm), then the increase of the unit cell parameter  $a(x)$  of  $TiCo_{1-x}Mn_xSb$  in the concentration range  $x = 0-0.05$  is logical (Fig. 2b). Such behavior of the parameter  $a(x)$  should indicate the realization of  $TiCo_{1-x}Mn_xSb$  substitutional solid solution, where structural defects of acceptor nature are generated in the crystallographic site  $4c$  of  $Co$  atoms. In this case, an impurity acceptor band  $\varepsilon_A^{Mn}$  should be formed in the band gap  $\varepsilon_g$  of the semiconductor.

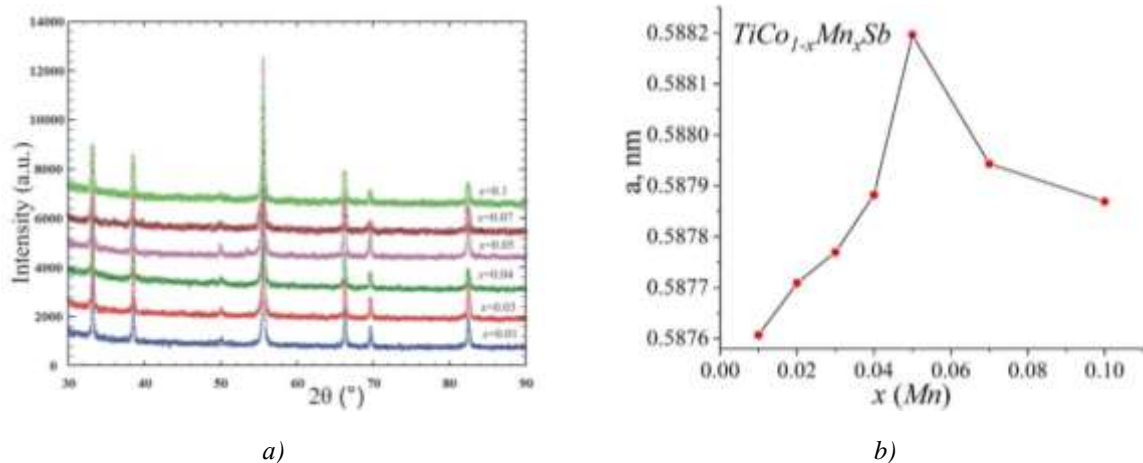


Fig. 2. X-ray powder diffraction patterns of samples (a) and variation of the unit cell parameter  $a(x)$  (b) for  $TiCo_{1-x}Mn_xSb$

However, the appearance of an extremum on the dependence  $a(x)$  of  $TiCo_{1-x}Mn_xSb$  at  $x = 0.05$ , followed by a decrease of the unit cell parameter  $a(x)$  at  $x > 0.05$  do not fit into the logic of forming a substitutional solid solution when  $Co$  atoms are replaced by  $Mn$  atoms. Thus, if the concentration of impurity  $Mn$  atoms at  $x = 0.05$  would be the limit of the existence of solid substitution (the limit of solubility of these atoms in the semiconductor structure matrix), then the value of the unit cell parameter  $a(x)$  of  $TiCo_{1-x}Mn_xSb$  should not change significantly. At the same time, the decrease in the values of  $a(x)$  of  $TiCo_{1-x}Mn_xSb$  at  $x > 0.05$  indicates the existence of a substitutional solid solution, but now the impurity  $Mn$  atoms occupy a different crystallographic position. In this connection, it is worth reminding the study of  $Ti_{1-x}V_xCoSb$  semiconductor [8], where the authors found the fact of simultaneous occupation of  $V$  ( $3d^34s^2$ ) impurity atoms both in the  $4a$  crystallographic position of  $Ti$  atoms, which generated structural defects of donor nature ( $V$  atom contains more electrons than  $Ti$  atom) and in the  $4c$  position of  $Co$  atoms, which generated defects of acceptor nature ( $V$  has fewer  $3d$ -electrons than  $Co$ ).

The most probable in  $TiCo_{1-x}Mn_xSb$  at  $x > 0.05$  is the occupation by the  $Mn$  atoms of the crystallographic position  $4a$  of the  $Ti$  atoms. Indeed, since the atomic radius of the  $Mn$  atom is smaller than that of  $Ti$  ( $r_{Ti} = 0.146$  nm), the decrease of the unit cell parameter  $a(x)$  for  $TiCo_{1-x}Mn_xSb$  at  $x > 0.05$  (Fig. 2b) becomes clear. In this case, structural defects of donor nature will be generated in crystallographic position  $4a$  ( $Mn$  atoms have a larger number of  $3d$ -electrons than  $Ti$ ), and the impurity donor band  $\varepsilon_D^{Mn}$  should be formed in the band gap  $\varepsilon_g$  of the  $TiCo_{1-x}Mn_xSb$  semiconductor.

We can assume that in a real  $TiCo_{1-x}Mn_xSb$  crystal these processes occur simultaneously, but the rate of substitution of certain atoms depends on the concentration of impurity  $Mn$  atoms. At lower concentrations of  $Mn$  atoms ( $x \leq 0.05$ ) they replace  $Co$  atoms to a greater extent, and at  $x > 0.05$  –  $Ti$

atoms. Herewith, donors and acceptors are generated simultaneously at different rates in  $TiCo_{1-x}Mn_xSb$ , and the semiconductor becomes heavily doped and highly compensated (HDHCS) [13].

However, taking into account the small number of impurity  $Mn$  atoms dissolved in the structure matrix of the initial semiconductor, as well as the poor accuracy of the X-ray method of studying the structure, we failed to record any other structural changes.

Thus, structural studies of the semiconductor thermoelectric material  $TiCo_{1-x}Mn_xSb$  showed a complex mechanism of impurity inclusion into the semiconductor matrix. The results of experimental investigations of electrokinetic properties for  $TiCo_{1-x}Mn_xSb$  will show the correspondence of the conclusions to the real processes in the crystal.

### Investigation of the electronic structure of $TiCo_{1-x}Mn_xSb$

To predict the behavior of the Fermi level  $\epsilon_F$ , the band gap  $\epsilon_g$ , and the electrokinetic characteristics of the  $TiCo_{1-x}Mn_xSb$  semiconductor, the distribution of density of electronic states (DOS) was calculated (Fig. 3) for an ordered variant of the structure when  $Ti$  atoms are substituted by  $Mn$  atoms in the crystallographic position 4a. From Fig. 3 we can see that in the base  $TiCoSb$  semiconductor the Fermi level  $\epsilon_F$  lies near the middle of the band gap  $\epsilon_g$ , but closer to the edge of the conduction band  $\epsilon_C$ . Since the substitution of  $Co$  atoms by  $Mn$  ones generates structural defects of acceptor nature, already at the concentration of  $TiCo_{0.99}Mn_{0.01}Sb$  the Fermi level  $\epsilon_F$  will drift from the conduction band  $\epsilon_C$  and will be located in the middle of the band gap  $\epsilon_g$ . At higher concentrations of the acceptor impurity, the concentration of acceptors will increase, and the Fermi level  $\epsilon_F$  will approach, and then will cross the percolation level of the valence band  $\epsilon_V$  of  $TiCo_{1-x}Mn_xSb$ , and the dielectric-metal conduction transition will occur [14].

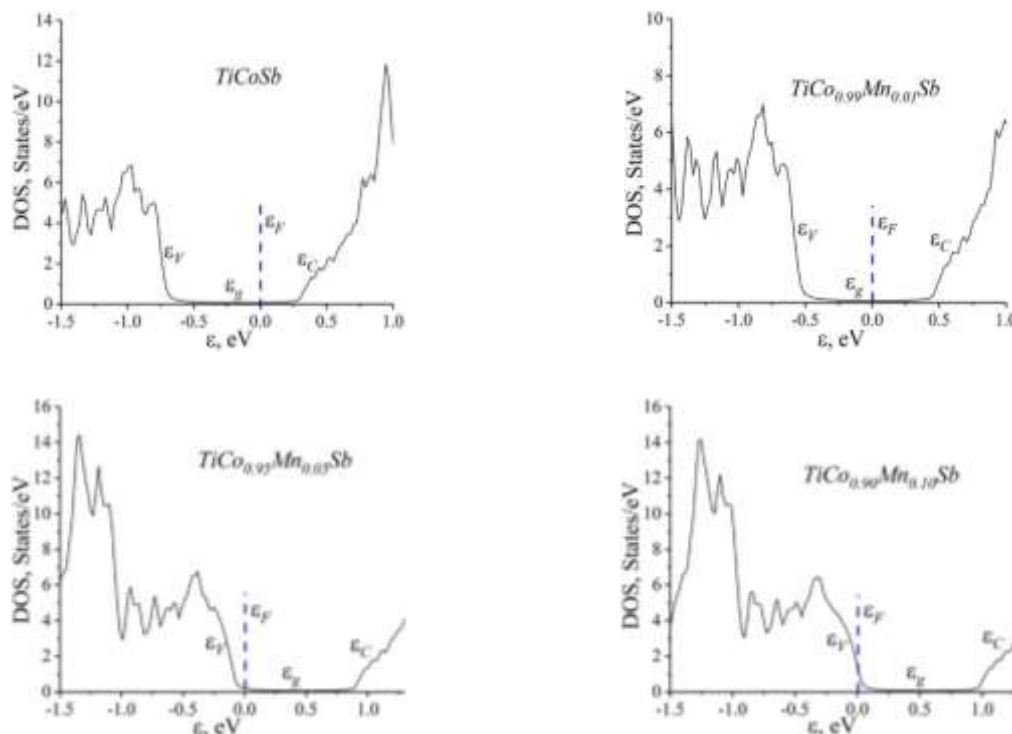


Fig. 3. Distribution of density of electronic states DOS for an ordered variant of the  $TiCo_{1-x}Mn_xSb$  structure



Approaching the Fermi level  $\varepsilon_F$  to the percolation level of the valence band  $\varepsilon_V$  will lead to the sign inversion of the Seebeck coefficient  $\alpha(T, x)$  from negative to positive, and the Fermi level  $\varepsilon_F$  crossing the percolation level of the valence band  $\varepsilon_V$  will change the conduction of the  $TiCo_{1-x}Mn_xSb$  semiconductor from activation to metal type [4, 13]. That is, in the experiment the activation parts will disappear on the dependences  $\ln(\rho(1/T))$ , and the values of the resistivity  $\rho$  will increase with temperature.

The calculation of distribution of the density of electronic states DOS for the ordered variant of the crystal structure of the thermoelectric material  $TiCo_{1-x}Mn_xSb$  allows modeling the behavior of electrokinetic characteristics (Fig. 4). In Fig. 4a, as an example, the results of variation of the Seebeck coefficient  $\alpha(x, T)$  are shown at different impurity concentrations and temperatures. As expected, the values  $\alpha(x, T)$  are positive at all concentrations and temperatures, and the maximum values  $\alpha(x, T)$  are reached at concentration  $x \approx 0.08$ . At the concentrations of  $Mn$  atoms,  $x \approx 0.08-0.10$ , the values of the thermoelectric power factor  $Z^*_{calc.}$  increase rapidly (Fig. 4b).

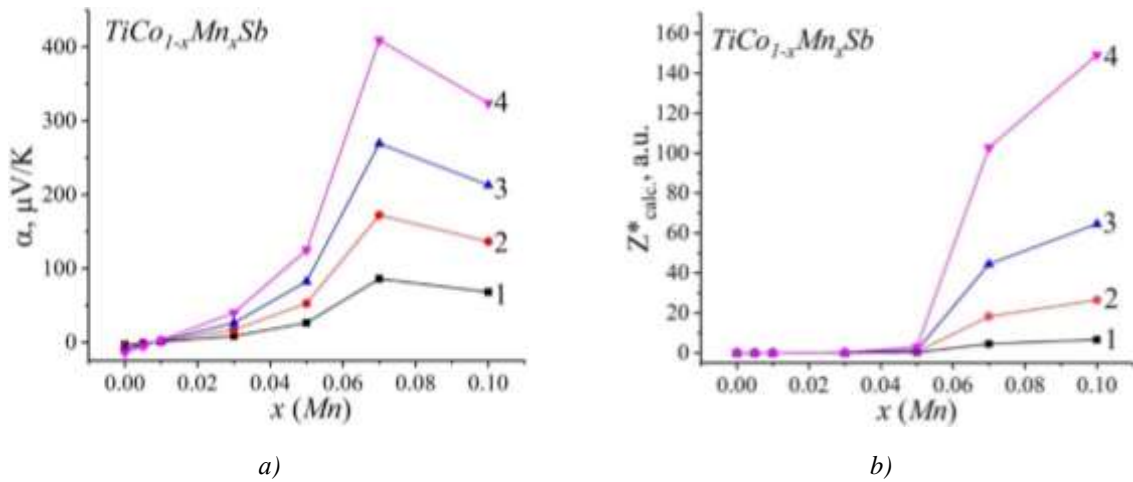


Fig. 4. Modeling of variation of the Seebeck coefficient  $\alpha$  (a) and the thermoelectric power factor  $Z^*_{calc.}$  (b) for an ordered variant of the  $TiCo_{1-x}Mn_xSb$  structure at temperatures: 1 – 80 K; 2 – 160 K; 3 – 250 K; 4 – 380 K

### Investigation of the electrokinetic and energy characteristics of $TiCo_{1-x}Mn_xSb$

Temperature and concentration dependences of electrical resistivity  $\rho$  and the Seebeck coefficient  $\alpha$  for  $TiCo_{1-x}Mn_xSb$  are given in Figs. 5–7.

The temperature dependence of the electrical resistivity  $\ln(\rho(1/T))$  for  $TiCoSb$  (Fig. 5) is typical for doped and compensated semiconductors and is described by known relation [13]:

$$\rho^{-1}(T) = \rho_1^{-1} \exp\left(-\frac{\varepsilon_1^\rho}{k_B T}\right) + \rho_3^{-1} \exp\left(-\frac{\varepsilon_3^\rho}{k_B T}\right), \quad (1)$$

where the first high-temperature term describes the activation of current carriers  $\varepsilon_1^\rho = 100.6$  meV from the Fermi level  $\varepsilon_F$  to the percolation level of the conduction band  $\varepsilon_C$ , and the second term, at low temperatures, – the hopping conduction with energy  $\varepsilon_3^\rho = 5.1$  meV at donors impurity states. As seen from Fig. 5, for  $TiCo_{1-x}Mn_xSb$  samples, except for the sample at  $x=0.05$ , the dependences  $\ln(\rho(1/T))$  are also described by relation (1).

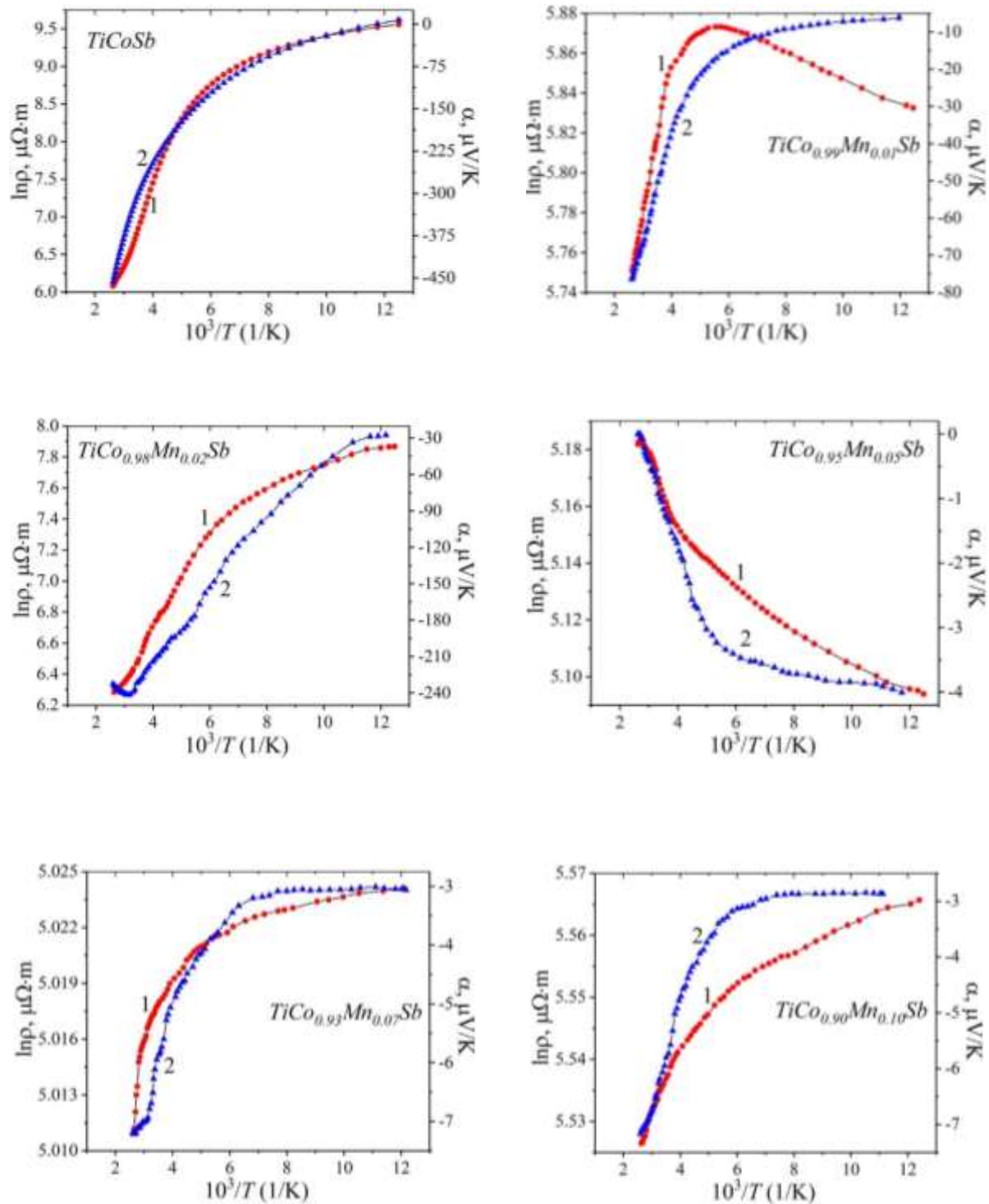


Fig. 5. Temperature dependences of electrical resistivity  $\ln(\rho(1/T))$  and the Seebeck coefficient  $\alpha(1/T)$  of thermoelectric material  $\text{TiCo}_{1-x}\text{Mn}_x\text{Sb}$

The variation of the Seebeck coefficient values  $\alpha(1/T)$  for  $\text{TiCo}_{1-x}\text{Mn}_x\text{Sb}$  (Fig. 5) is also a classic for doped and compensated semiconductors and is described by the relation [14]:

$$\alpha = \frac{k_B}{e} \left( \frac{\varepsilon_i^\alpha}{k_B T} - \gamma + 1 \right), \quad (2)$$

where  $\gamma$  is a parameter that depends on the nature of scattering. From the temperature dependence of  $\alpha(1/T)$  of *TiCoSb* at high temperatures, the value of activation energy  $\varepsilon_1^\alpha = 214.1$  meV is calculated, which is proportional to the amplitude of large-scale fluctuations of the continuous energies bands of heavily doped and highly compensated semiconductor [4, 13]. In turn, from the low-temperature dependence  $\alpha(1/T)$  at low temperatures, the value of activation energy  $\varepsilon_3^\alpha = 10.2$  meV is determined, which is proportional to the amplitude of modulation of small-scale fluctuation of HDHCS [4, 13].

The results of measuring the electrokinetic characteristics for the initial *TiCoSb* semiconductor are fully consistent with those previously obtained in Refs. [3–9]. The high compensation of *TiCoSb* (closeness of concentrations of ionized acceptors and donors) is evidenced by the character of the variation of the Seebeck coefficient  $\alpha$  (Figs. 5, 6). Indeed, *TiCoSb* is a semiconductor of the hole-type conduction at temperatures  $T = 80$ – $90$  K, as indicated by the positive values of the Seebeck coefficient:  $\alpha_{80\text{ K}} = 7.75$   $\mu\text{V/K}$  and  $\alpha_{90\text{ K}} = 0.71$   $\mu\text{V/K}$ . However, at higher temperatures, the sign of the Seebeck coefficient  $\alpha$  of *TiCoSb* becomes negative ( $\alpha_{95\text{ K}} = -6.33$   $\mu\text{V/K}$ ), indicating electrons as the majority charge carriers.

Doping the initial semiconductor *TiCoSb* by the lowest concentration of impurity *Mn* atoms,  $x = 0.01$ , leads to substantial changes in the temperature dependence  $\ln(\rho(1/T))$  (see Fig. 5). The presence of a high-temperature activation part on the  $\ln(\rho(1/T))$  dependence for *TiCo<sub>0.99</sub>Mn<sub>0.01</sub>Sb* is evidence of the location of the Fermi level  $\varepsilon_F$  within the band gap  $\varepsilon_g$ , and the negative values of the Seebeck coefficient  $\alpha(T, x)$  (Figs. 5, 6) specify its position which is at a distance of  $\sim 6$  meV from the percolation level of the conduction band  $\varepsilon_C$  (Fig. 7). In this case, the electrons are the majority carriers of the semiconductor.

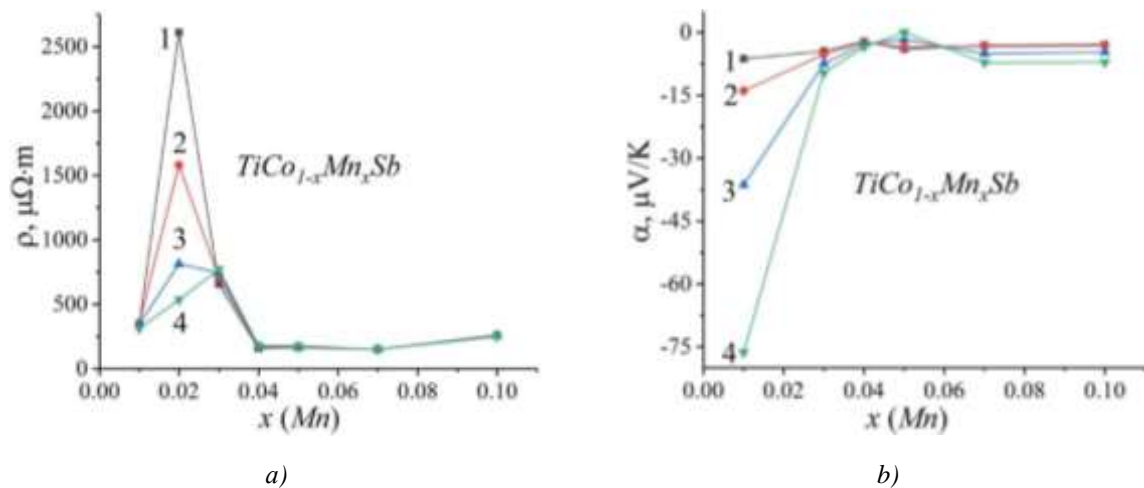


Fig. 6. Variation of electrical resistivity  $\rho(x, T)$  (a) and the Seebeck coefficient  $\alpha(x, T)$  (b) for *TiCo<sub>1-x</sub>Mn<sub>x</sub>Sb* at different temperatures: 1 – 80 K, 2 – 160 K, 3 – 250 K, 4 – 380 K

The fact that there is no mechanism of hopping conduction  $\varepsilon_3^p$  at low temperatures in *TiCo<sub>0.99</sub>Mn<sub>0.01</sub>Sb* (low-temperature activation part is absent on the dependence  $\ln(\rho(1/T))$ ) indicates a significant number of donors, which exceeds the concentration of introduced acceptors. There is an overlap of the wave functions of the electrons of impurity states near the Fermi level  $\varepsilon_F$ , which makes the mechanism of hopping conduction needless [13].



Negative values of the Seebeck coefficient  $\alpha(T,x)$  for  $TiCo_{0.99}Mn_{0.01}Sb$  in the temperature range 80–400 K (Figs. 5, 6), when the concentrations of acceptors and donors are close according to DOS calculations (Fig. 3), can be explained by a slightly higher concentration of uncontrolled donors over acceptors. But even at higher impurity  $Mn$  concentration, in  $TiCo_{0.98}Mn_{0.02}Sb$ , the sign of the Seebeck coefficient  $\alpha(T,x)$  is negative. An increase in the value of resistivity  $\rho(x,T)$  was observed, for example, at temperature  $T = 80$  K from  $\rho(x = 0.01) \approx 341 \mu\Omega \cdot m$  to  $\rho(x = 0.02) \approx 2612 \mu\Omega \cdot m$  (Fig. 6a). This increase in the values of  $\rho(x,T)$  is evidence of an increase in the compensation degree of the semiconductor, which will lead to the appearance of the hopping conduction mechanism  $\varepsilon_3^p$  at low temperatures (low-temperature activation part appears on the dependence  $\ln(\rho(1/T))$ ).

The change of the position of the Fermi level  $\varepsilon_F$  in the sample  $TiCo_{0.98}Mn_{0.02}Sb$ , which has shifted from the percolation level of the conduction band  $\varepsilon_C$  at the distance of  $\sim 30$  meV (Fig. 7), is evidence of an increase of the compensation degree of semiconductor (reduction of the difference between ionized donors and acceptors). Therefore, the increase in the values of the resistivity  $\rho(x,T)$  of  $TiCo_{1-x}Mn_xSb$  in the concentration range  $x = 0.01$ – $0.02$  is a direct proof of the generation of acceptors in the crystal when the  $Co$  atoms are substituted by  $Mn$  atoms. This generation of acceptors leads to the capture of free electrons, which reduces their concentration and causes an increase of the resistivity values  $\rho(x,T)$ . On the other hand, the negative values of the Seebeck coefficient  $\alpha(x,T)$  are also experimental evidence that the  $TiCo_{1-x}Mn_xSb$  semiconductor has a significant concentration of donors that is greater than the number of introduced acceptors ( $x = 0.02$ ), or in the crystal acceptors and donors are generated simultaneously by different mechanisms.

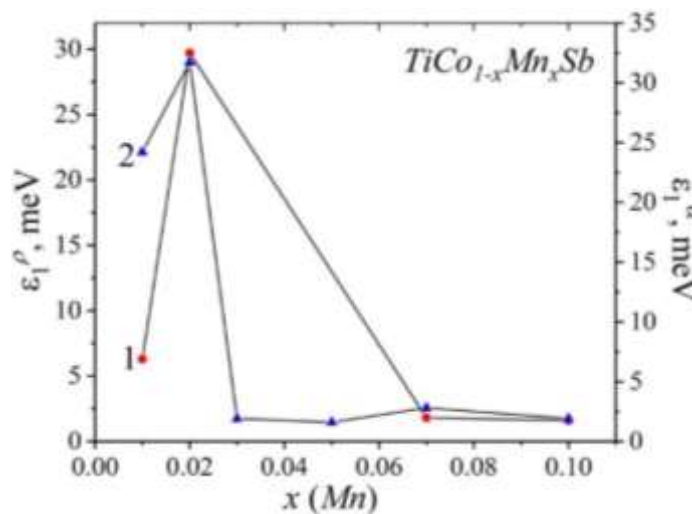


Fig. 7. Variations of the activation energies values  $\varepsilon_1^{\alpha}$  (1) and  $\varepsilon_1^{\alpha}$  (2) for  $TiCo_{1-x}Mn_xSb$

The appearance of the maximum on the dependence of the resistivity  $\rho(x, T)$  of  $TiCo_{1-x}Mn_xSb$  (Fig. 6a) is an argument that the generation rates of acceptors and donors in the semiconductor are different. At the point of maximum of dependence  $\rho(x, T)$  for  $TiCo_{1-x}Mn_xSb$ , these rates are balanced. However, the number of acceptors is slightly less than the number of free electrons. This is indicated by the negative values of the Seebeck coefficient  $\alpha(x, T)$  (Fig. 6b). Thus, at  $T = 80$  K, to balance the ionized acceptors and donors, it is necessary to introduce a concentration of  $Mn$  atoms ( $x = 0.02$ ) that generates acceptors so that the concentrations of holes and electrons are close. At higher temperatures, ionization of deep donor states takes place, which increases the concentration of electrons, and

therefore it is necessary to introduce a higher concentration of impurity  $Mn$  atoms into the crystal ( $x = 0.03$ ). It is logical that the maximum on the dependence  $\rho(x, T)$  appears at  $x = 0.03$  (Fig. 6a). The fact of shifting the maximum on the dependence  $\rho(x, T)$  with increasing temperature is evidence of the existence of several mechanisms for generating donors of different nature (origin), which generate in the band gap  $\varepsilon_g$  donor bands  $\varepsilon_D^1$  and  $\varepsilon_D^2$  of different nature with different depths of their location relative to the percolation level of the conduction band  $\varepsilon_C$ .

The experimental result described above does not correspond to the conclusions made in the calculations of the electronic structure of the  $TiCo_{1-x}Mn_xSb$  semiconductor for the ordered variant of its crystal structure (Fig. 3). When  $Co$  ( $3d^7 4s^2$ ) atoms are substituted by  $Mn$  ( $3d^5 4s^2$ ) atoms in  $TiCo_{1-x}Mn_xSb$ , acceptors should be generated in the semiconductor, which will capture all free electrons at concentration  $x \approx 0.02$ . This process must not be accompanied by inversion of the sign of the Seebeck coefficient  $\alpha$ , and free holes will remain the majority charge carriers of the semiconductor (Fig. 4a). We can assume that more complex structural changes occur in  $TiCo_{1-x}Mn_xSb$  than the substitution of  $Co$  atoms by  $Mn$ . At the same time, structural defects of acceptor and donor nature are generated in the crystal by different mechanisms, but the concentration of donors exceeds the concentration of acceptors.

Calculations of the location depth of the Fermi level  $\varepsilon_F$  relative to the percolation level of the conduction band  $\varepsilon_C$  of  $TiCo_{1-x}Mn_xSb$  at a higher concentration of impurity  $Mn$  atoms ( $x \geq 0.07$ ) (the sign of the Seebeck coefficient  $\alpha(T, x)$  is negative) showed that the Fermi level  $\varepsilon_F$  very closely approached the percolation level:  $\varepsilon_F(x = 0.07) = 1.8$  meV and  $\varepsilon_F(x = 0.10) = 1.6$  meV (Fig. 7). The presence of high- and low-temperature activation parts on the  $\ln(\rho(1/T))$  dependences of  $TiCo_{1-x}Mn_xSb$  at  $x \geq 0.07$  is possible provided semiconductor compensation (simultaneous existence of ionized donors and acceptors). However, the fact that the Fermi level  $\varepsilon_F$  lies within the band gap  $\varepsilon_g$  near the percolation level of the conduction band indicates a weak compensation of the semiconductor, when the concentration of free electrons is much higher than the concentration of holes.

What is the reason for such, at first glance, illogical behavior of electrokinetic and energy characteristics in the semiconductor thermoelectric material  $TiCo_{1-x}Mn_xSb$ ?

If we remind that in the structure of the base semiconductor  $TiCoSb$  there are simultaneously  $\sim 1\%$  of vacancies in position 4a of the  $Ti$  atoms that generate acceptors, and in the tetrahedral voids of the structure there are  $\sim 1\%$  of additional  $Co^*$  atoms that generate donors [3], the situation becomes clearer. In turn, structural studies of  $TiCo_{1-x}Mn_xSb$  showed that the introduction of impurity  $Mn$  atoms into the disordered structure of the base semiconductor  $TiCoSb$  is accompanied by its ordering. This means that the vacancies in position 4a of the  $Ti$  atoms, and also the corresponding acceptor band  $\varepsilon_A$  disappear. Instead, the  $Ti$  atoms occupying the vacancies in position 4a are a source of electrons that generates the donor band  $\varepsilon_D^1$ . Partial occupation of tetrahedral voids of the structure by impurity  $Mn$  atoms is a mechanism of the formation of another donor band  $\varepsilon_D^2$ .

## Conclusions

The result of a complex investigation of the crystal and electronic structures, electrokinetic and energy characteristics of the thermoelectric material  $TiCo_{1-x}Mn_xSb$  is the establishment of the nature of structural defects of donor and acceptor nature. It was shown that doping of the base semiconductor  $TiCoSb$  by  $Mn$  atoms simultaneously generates the acceptor band  $\varepsilon_A$  (substitution of  $Co$  atoms by  $Mn$ ) and the donor bands  $\varepsilon_D^1$  and  $\varepsilon_D^2$  of different nature. The ratio of the concentrations of ionized acceptors and donors generated in  $TiCo_{1-x}Mn_xSb$  determines the position of the Fermi level  $\varepsilon_F$  and the

mechanisms of electrical conduction. However, this issue requires additional research, in particular, modeling the electronic structure of thermoelectric material under different conditions of introduction into the structure and concentrations of impurity *Mn* atoms. The investigated  $TiCo_{1-x}Mn_xSb$  solid solution is a promising thermoelectric material.

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## **ДОСЛІДЖЕННЯ ЕНЕРГЕТИЧНИХ ТА КІНЕТИЧНИХ ХАРАКТЕРИСТИК ТЕРМОЕЛЕКТРИЧНОГО МАТЕРІАЛУ $TiCo_{1-x}Mn_xSb$**

Досліджено кристалічну та електронну структури, температурні і концентраційні залежності питомого електроопору та коефіцієнта термо-ерс термоелектричного матеріалу  $TiCo_{1-x}Mn_xSb$ ,  $x = 0.01-0.10$ , у діапазоні температур  $T = 80-400$  К. Показано, що легування базового напівпровідника  $TiCoSb$  атомами  $Mn$  супроводжується одночасним генеруванням структурних дефектів акцепторної та донорної природи та появою в забороненій зоні акцепторної  $\epsilon_A$  (заміщення атомів  $Co$  на  $Mn$ ) і донорних зон  $\epsilon_D^1$  та  $\epsilon_D^2$  різної природи. Співвідношення генерованих у  $TiCo_{1-x}Mn_xSb$  концентрацій іонізованих акцепторів і донорів визначає положення рівня Фермі  $\epsilon_F$  та механізми електропровідності термоелектричного матеріалу. Бібл. 14, рис. 7.

**Ключові слова:** електронна структура, електроопір, коефіцієнт термоЕРС.

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## ИССЛЕДОВАНИЕ ЭНЕРГЕТИЧЕСКИХ И КИНЕТИЧЕСКИХ ХАРАКТЕРИСТИК ТЕРМОЭЛЕКТРИЧЕСКИХ МАТЕРИАЛОВ $TiCo_{1-x}Mn_xSb$

Исследованы кристаллическая и электронная структуры, температурные и концентрационные зависимости удельного электросопротивления и коэффициента термоЭДС термоэлектрического материала  $TiCo_{1-x}Mn_xSb$ ,  $x = 0.01 - 0.10$ , в диапазоне температур  $T = 80 - 400$  К. Показано, что легирования базового полупроводника  $TiCoSb$  атомами Mn сопровождается одновременным генерированием структурных дефектов акцепторной и донорной природы и появлением в запрещенной зоне акцепторной  $\epsilon_A$  (замещение атомов Co на Mn) и донорных зон  $\epsilon_D^1$ ,  $\epsilon_D^2$  различной природы. Соотношение генерируемых в  $TiCo_{1-x}Mn_xSb$  концентраций ионизированных акцепторов и доноров определяет положение уровня Ферми  $\epsilon_F$  и механизмы электропроводности термоэлектрического материала. Библ. 14, рис. 7.

**Ключевые слова:** Электронная структура, электросопротивление, коэффициент термоЭДС

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